# Semiconductor Testing Solutions





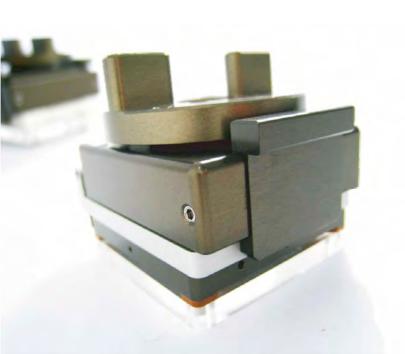
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C.C.P Contact Probes Co., Ltd. was founded in 1986 with the goal "to set new quality standards in the industry and put customer satisfaction at the core of the business." C.C.P. has started as a specialized provider of test probes and socket auxiliary solutions and has slowly expanded its product portfolio in related industries such as electronic component manufacturing. Our customized manufacturing equipment and strong research team enable us to stay at the forefront of the industry and develop products that reach the highest standards in terms of quality and availability.

After years of continuous growth, C.C.P. went public in 2001 and got listed on the Taiwan Stock Exchange in 2003. As of today, C.C.P. has subsidiaries in the U.S.A., China, Germany, India, Singapore, Japan and Korea, meeting demands from customers around the globe.

Apart from superior product quality, C.C.P. is committed to delivering excellent customer support, fast responses, and engaging customer interaction.

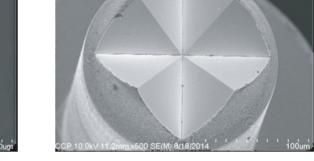




# C.C.P. Strengths

# Mirror process





Normal

Mirror process

C.C.P. consistently delivers high-quality products by optimizing the production process. The results are extremely durable and reliable products that meet our client's expectations.

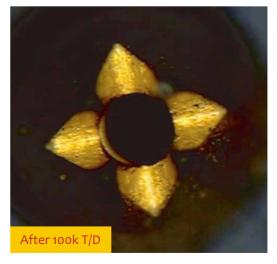
One of these cutting-edge technologies is called "Mirror Process" which significantly improves the surface quality of the pin tip.

- Less chance for solder migrating
- Less probe cleaning neccessary

Tip appearance comparison after 100,000 touchdowns



Normal



Mirror process

# C.C.P. Strengths

# **Plating Line**



C.C.P. is specialized in thick-layer Au-plating (over 1500 "), blind-hole plating (Aspect Ratio >6.5:1), precious metals processing (Pd alloy), etc.

C.C.P. has its own plating facility and technology. All materials we receive go through a strict quality control and materials used are certified by RoHS. Our plating technology is the result of more than 20 years of in-house research and delivers an industry leading performance for our products.



# **Advanced Analysis Equipment**



Surface roughness inspection and measurement.



Plating hardness measurement.



Surface observation with EDS for material analysis.



# **Product Number Chart**

#### PE 1-031 DF 21-01 F0 Plating and raw material DE BeCu/SK4, Au plated **Manufacturing Procedure** A0 Standard Manufacturing Process PE Pd alloy w/o plating FO Mirror Process WE BeCu, WJ3 plated Structure Type 1 Double-active **Serial Number** 2 Double-active with Ring 3 Single-active 4 Single-active with Ring Barrel Outer Diameter Ex 031 corresponds with barrel OD $\Phi$ 0.31mm Barrel Length Ex 21 corresponds with barrel length 2.1mm **Head Type** Crown Conical 60° Easily penetrates into Sharper tip to strongly solder ball or pad for penetrate the oxide or improved contact. particle on PCB. **Pyramid Crown** Conical 90°, 120° Easily penetrates into solder Sharper tip to softly penetrate ball or pad with stronger tips the oxide or particle on PCB. for improved contact. Serrated 5 Tips Sphere Easily penetrates into solder For avoiding probe mark on ball or pad with more contact PCB. It is usually used in points than crown type. bottom plunger. Flat Serrated Mostly used in bottom Usually used for Kelvin Tests plunger to avoid scratching that have a very small pitch PCB gold pad and leaving between the probe tips. no marks or indentations. Serrated Half Moon 9 Tips Used for Kelvin type. Pointing Easily penetrates into solder to ball / pad, half moon tip ball or pad with more contact perfectly aims the testing area. points than crown type. Blade Cup Sharper than half moon tip, Commonly used for testing blade type is more commonly PGA package types of IC. used in Kelvin pin as for standard types.











# **General Final Test**

C.C.P. has over 25 years of experience in the development and manufacturing of sockets and pins. Our research and development teams are constantly improving the materials and manufacturing process to offer our customers the best solutions. We have developed more than 300 customized pins and over 50 special pins that are designed to withstand high currents, high-temperature environments or can handle high frequency data transmission.

# **Design Concept**

# Applied IC package BGA, QFN, QFP, LGA, CSP

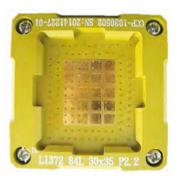


QFN Socket Pitch o.3mm



BGA Socket Pitch o.8mm

# Pitch 0.2~2.2mm



LGA Socket Pitch:2.2mm

General IC Test Socket	Specification		
IC Package Size	1.5X1.5~38X38 mm²		
Min. Pitch	o.2mm		
Material	Torlon 4203, Torlon 5530, PEEK, PEEK ceramic, SCP 5000		
Data Rate	6 Gpbs/8 Gpbs/12 Gpbs Performance will be different according to testing condition		
Life Time (Pin)	>200K		

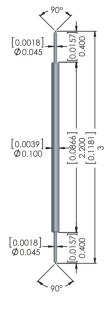




Block

Unit:mm; [ ]:in

#### PE1-010EE22-01A0



#### Material

Top Plunger
Pd alloy
Barrel
Ni alloy
Spring
SWP , Au plated
Bottom Plunger
Pd alloy

### Mechanical Spec.

Recommened Travel

0.35mm

Full Travel

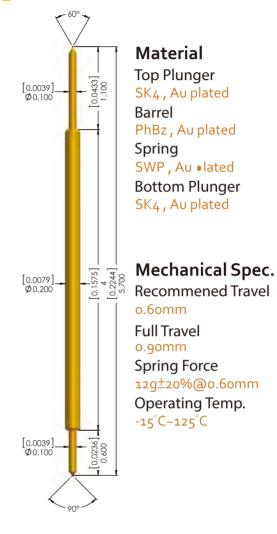
o.50mm

Spring Force 7g±20%@0.35mm

Operating Temp.

-15°C~125°C

#### DE1-020BE40-01A0



#### Electrical Spec.



Pitch: 0.2mm Socket Material: Peek 1000 
Current Rating 0.6A continuous 
Contact Resistance <300m $\Omega$ (AVG) 
Characteristic Impedance 80.8 $\Omega$  
Insertion Loss -1dB@9.9GHz 
Return Loss -2odB@2.48GHz 
Time Delay 13.74 psec

Loop Inductance 1.11 nH Capacitance 0.17 pF

#### **Electrical Spec.**

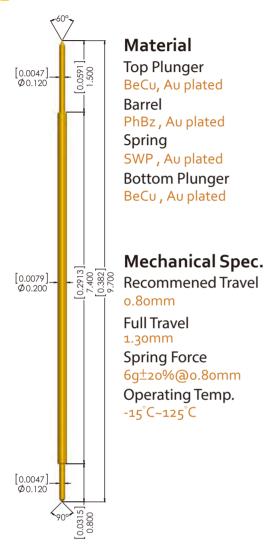


Current Rating 1A continuous Contact Resistance  $<200 \text{m}\Omega(\text{AVG})$  Characteristic Impedance  $55.9\Omega$  Insertion Loss -1 dB > 20 GHz Return Loss  $-20 \text{dB} \otimes 12.88 \text{GHz}$  Time Delay 26.83 psec Loop Inductance 1.5 nH Capacitance 0.48 pF

Unit:mm; [ ]:in

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#### DE1-020BE74-01A0

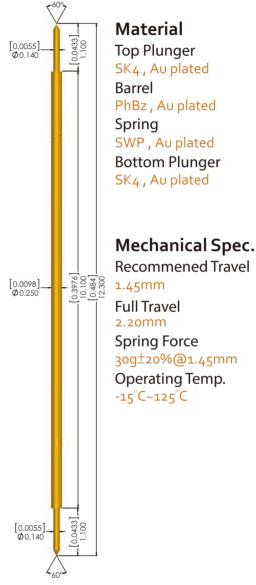


#### **Electrical Spec.**



Pitch: 0.3mm Socket Material: Peek 1000 Current Rating 0.5A continuous Contact Resistance <200m $\Omega$ (AVG) Characteristic Impedance  $53.07\Omega$  Insertion Loss -1dB >20GHz Return Loss -20dB@8.14GHz Time Delay 46.17psec Loop Inductance 2.45 nH Capacitance 0.87 pF

#### DE1-025BB10-02A0



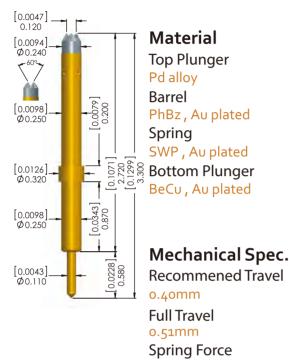
#### **Electrical Spec.**



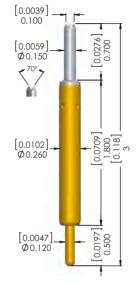
Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$  Characteristic Impedance  $51.31\Omega$  Insertion Loss -1dB>20GHz Return Loss -20dB@7.63GHz Time Delay 55.93 psec Loop Inductance 2.87 nH Capacitance 1.09 pF

Unit:mm; [ ]:in

#### PE4-025EF24-01A0



#### PE3-026DF17-01F0



Material Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

## Mechanical Spec.

**Recommened Travel** 

0.35mm

**Full Travel** 

o.50mm

Spring Force 20q±20%@0.35mm

Operating Temp.

-15°C~125°C

#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000



23g±20%@0.40mm

Operating Temp.

-15°C~125°C

Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ 

Characteristic Impedance  $50.15 \Omega$ 

Insertion Loss -1dB>20GHz Return Loss -2odB>2oGHz

Time Delay 16.55 psec

Loop Inductance o.83 nH

Capacitance 0.33 pF

#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $57.68\Omega$ Insertion Loss -1dB>20GHz

Return Loss -20dB@9.16GHz

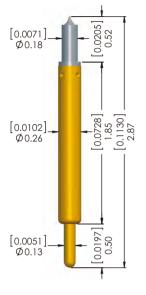
Time Delay 13.31 psec Loop Inductance 0.77 nH

Capacitance 0.23 pF

Unit:mm; [ ]:in

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#### PE3-026BD18-01A0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au • lated **Bottom Plunger** BeCu, Au plated

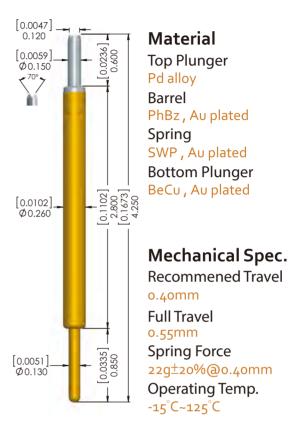
#### Mechanical Sec.

**Recommened Travel** 

o.30mm

**Full Travel** o.40mm **Spring Force** 24g±20%@0.30mm Operating Temp. -15°C~125°C

#### PE3-026DF27-01F0



#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000



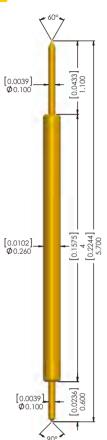
Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance 54.77  $\Omega$ Insertion Loss -1dB@>20GHz Return Loss -20dB@16GHz Time Delay 12.6 psec Loop Inductance o.69 nH Capacitance 0.23 pF

#### **Electrical Spec.**

Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $54\Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@18.9GHz Time Delay 21.7 psec Loop Inductance 1.18 nH Capacitance 0.40 pF

Unit:mm; [ ]:in

#### DE1-026BE40-01A0



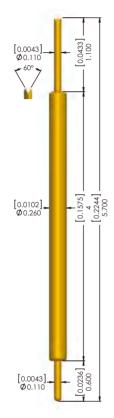
# Material

**Top Plunger** BeCu, Au plated Barrel PhBz, Au plated Spring SUS, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 0.65mm **Full Travel** 1.00mm **Spring Force** 14g±20%@0.65mm Operating Temp. -55°C~150°C

#### DE1-026DF40-02A0



#### Material

**Top Plunger** BeCu, Au plated Barrel PhBz, Au plated Spring SUS, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 0.65mm **Full Travel** 0.85mm **Spring Force** 18g±20%@0.65mm Operating Temp.

-55°C~150°C

#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance <175m $\Omega(AVG)$ Characteristic Impedance  $49.46\Omega$ Insertion Loss -1dB@16.7 GHz Return Loss -20dB@8.23GHz Time Delay 27.7 psec Loop Inductance 1.37 nH Capacitance 0.56 pF

#### **Electrical Spec.**

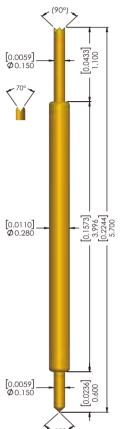


Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $47.71 \Omega$ Insertion Loss -1dB@17.81GHz Return Loss -20dB@6.45GHz Time Delay 27.67 psec Loop Inductance 1.32 nH Capacitance 0.58 pF

Unit:mm; [ ]:in

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#### DE1-028EF40-05A0



#### **Material**

Top Plunger SK<sub>4</sub>, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** SK<sub>4</sub>, Au plated

#### Mechanical Spec.

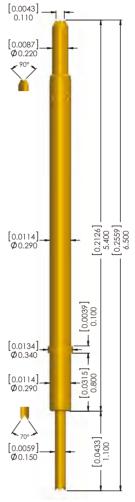
Recommened Travel 0.65mm

**Full Travel** 1.10mm

**Spring Force** 28g±20%@0.65mm

Operating Temp. -15°C~125°C

#### DE4-029FF45-01A0



# Material

Top Plunger SK<sub>4</sub>, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

# Mechanical Spec.

**Recommened Travel** o.70mm

**Full Travel** 1.10mm Spring Force

30g±20%@0.70mm Operating Temp.

-15°C~125°C

#### **Electrical Spec.** Pitch: o.4mm Socket Material: Pee



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $49.6\Omega$ Insertion Loss -1dB@17.49GHz Return Loss -20dB@ 7.92GHz Time Delay 27.7 psec

Loop Inductance 1.38nH Capacitance 0.56 pF

#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 44.38Ω Insertion Loss -1dB>20GHz Return Loss -2odB@3.77GHz Time Delay 28.84 psec

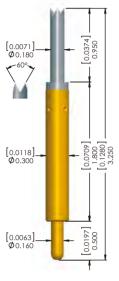
Loop Inductance 1.28 nH

Capacitance 0.65 pF

# **Probe Specifications**

Unit:mm; [ ]:in

#### PE3-030DF17-03A0



#### Material

Top Plunger Pd alloy

Barrel PhBz, Au plated Spring SWP, Au plated

**Bottom Plunger** BeCu, Au plated

### Mechanical Spec.

**Recommened Travel** 

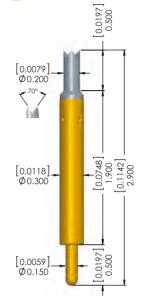
0.35mm

Full Travel 0.45mm

Spring Force 27g±20%@0.35mm

Operating Temp. -15°C~125°C

#### PE3-030DF18-01A0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 

o.40mm

Full Travel o.50mm Spring Force 35g±20%@0.40mm

Operating Temp. -15°C~125°C

#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $48.19 \Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@8.59GHz

Time Delay 14.94 psec Loop Inductance 0.72 nH Capacitance 0.31 pF

#### **Electrical Spec.**

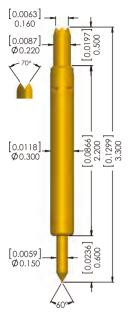


Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $42.36\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@6.47GHz Time Delay 14.4 psec Loop Inductance 0.61 nH Capacitance 0.34 pF

Unit:mm; [ ]:in

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#### DE3-030BF21-03F0



#### Material

Top Plunger BeCu, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

# Mechanical Spec.

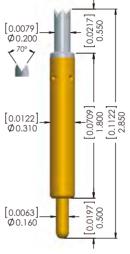
Recommened Travel

o.4omm

**Full Travel** 0.55mm **Spring Force** 30g±20%@0.40mm Operating Temp.

-15°C~125°C

#### PE3-031DF17-03F0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

Recommened Travel

0.35mm

**Full Travel** 0.45mm **Spring Force** 35g±20%@0.35mm Operating Temp. -15°C~125°C

#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $42\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@7.15GHz Time Delay 16.4 psec Loop Inductance o.69nH Capacitance 0.39 pF

#### **Electrical Spec.**



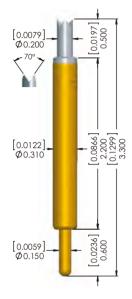


Loop Inductance 0.59 nH Capacitance 0.37 pF

# **Probe Specifications**

Unit:mm; [ ]:in

#### PE3-031DF21-03F0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

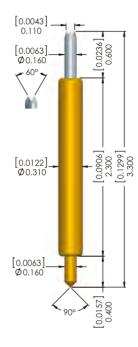
#### Mechanical Spec.

**Recommened Travel** 0.35 mm

**Full Travel** o.6omm Spring Force 35g±20%@0.35mm Operating Temp.

-15°C~125°C

#### PE1-031EF23-02F0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical S•ec. Recommened Travel

o.40mm **Full Travel** 0.65mm **Spring Force** 30g±20%@0.40mm Operating Temp. -15°C~125°C

#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $42.67\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@5.08GHz Time Delay 16.64 psec Loop Inductance 0.71nH Capacitance 0.39 pF

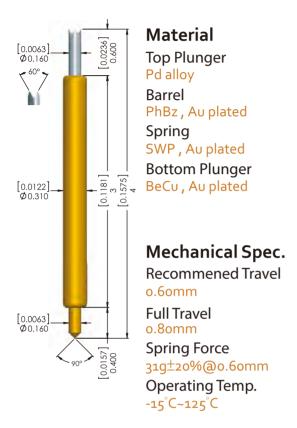
#### **Electrical Spec.**



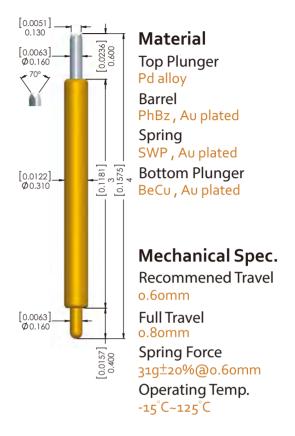
Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $40.14 \Omega$ Insertion Loss -1dB >20GHz Return Loss -2odB@4.15GHz Time Delay 14.45 psec Loop Inductance o.58 nH Capacitance 0.36 pF

Unit:mm; [ ]:in

#### PE1-031EF30-02F0



#### PE1-031DF30-01F0



#### **Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000

Current Rating 1A continuous Contact Resistance <175m $\Omega(AVG)$ Characteristic Impedance  $39.53\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@3.63GHz Time Delay 18.97 psec Loop Inductance 0.75 nH Capacitance o.48 pF

#### **Electrical Spec.**



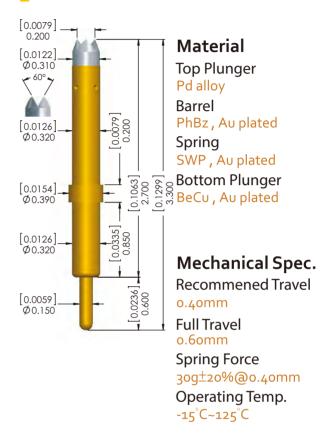
Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $40 \Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@3.9GHz Time Delay 19.7 psec Loop Inductance o.8 nH Capacitance 0.49 pF

#### Unit:mm; [ ]:in

#### DE1-031DG40-01A0

#### Material Top Plunger [0.0433] 1.100 0.0059 Ø0.150 BeCu, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated [0.0122] Ø0.310 Mechanical Spec. **Recommened Travel** 0.65mm **Full Travel** 1.10mm **Spring Force** 37g±20%@0.65mm Operating Temp. [0.0059] Ø0.150 -15°C~125°C

#### PE4-032DF24-03F0



#### **Electrical Spec.**



Pitch: 0.4mm Socket Material: Peek 1000 Current Rating 1A continuous Contact Resistance <175m $\Omega$ (AVG) Characteristic Impedance 42.8 $\Omega$  Insertion Loss -1dB@17.68GHz Return Loss -2odB@4.05GHz Time Delay 27.97 psec Loop Inductance 1.2 nH Capacitance 0.65 pF

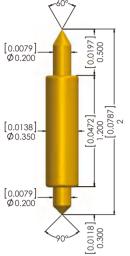
#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance  $<75\text{m}\Omega(\text{AVG})$  Characteristic Impedance  $43.3\,\Omega$  Insertion Loss -1dB>20GHz Return Loss -20dB@5.44GHz Time Delay  $18.2\,\text{psec}$  Loop Inductance  $0.79\,\text{nH}$  Capacitance  $0.42\,\text{pF}$ 

Unit:mm; [ ]:in

#### DE1-035BE12-01A0



#### **Material**

Top Plunger BeCu, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

### Mechanical Spec.

**Recommened Travel** 

o.30mm

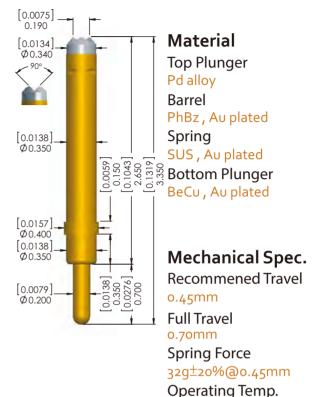
**Full Travel** o.40mm

**Spring Force** 18g±20%@0.30mm

Operating Temp.

-15°C~125°C

#### PE4-035DF24-01F0



#### Electrical Spec. Pitch: 0.5mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $34.74\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@4.08GHz Time Delay 10.07 psec Loop Inductance 0.35nH Capacitance 0.29pF

#### Electrical Spec.



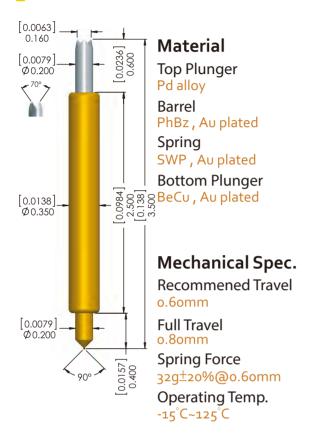


-55°C~150°C

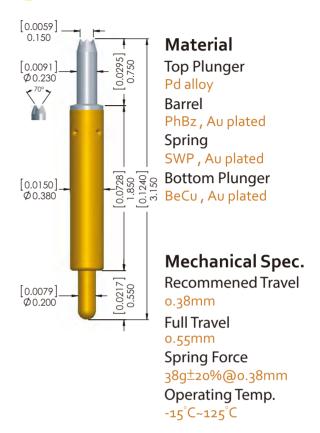
Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance 39.8 Ω Insertion Loss -1dB>20GHz Return Loss -20dB@3.94GHz Time Delay 17.5 psec Loop Inductance 0.70 nH Capacitance 0.44 pF

Unit:mm; [ ]:in

#### PE1-035EF25-01F0



#### PE3-038DF17-03F0



#### Electrical Spec.

Capacitance 0.42pF



Pitch: 0.5mm Socket Material: Peek 1000 Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance 44Ω Insertion Loss -1dB>20GHz Return Loss -2odB@ 8.48GHz Time Delay 18.5psec Loop Inductance o.82nH

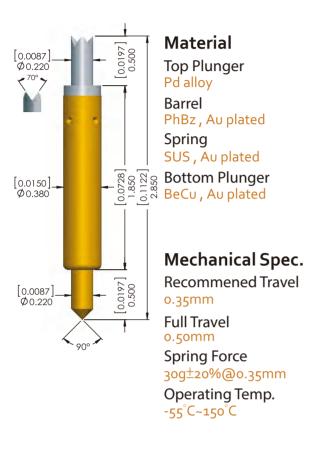
#### Electrical Spec.



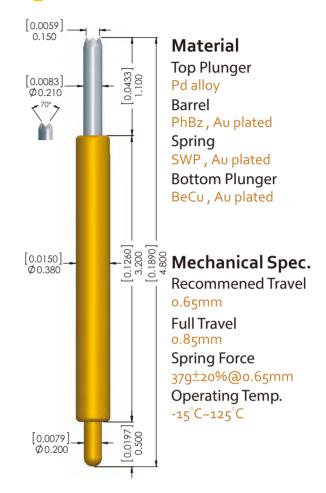
Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 45.08 Ω Insertion Loss -1dB>20GHz Return Loss -2odB@5.69GHz Time Delay 13.97 psec Loop Inductance o.63 nH Capacitance 0.31 pF

Unit:mm; [ ]:in

#### PE3-038EF17-04A0



#### PE1-038DF32-02F0



#### Electrical Spec.



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 39.8 Ω Insertion Loss -1dB>20GHz Return Loss -2odB@4.5GHz Time Delay 15.5 psec Loop Inductance o.62 nH Capacitance 0.39 pF

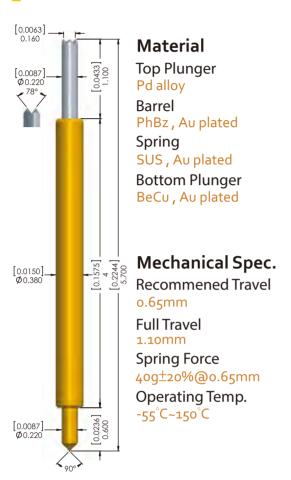
#### Electrical Spec.



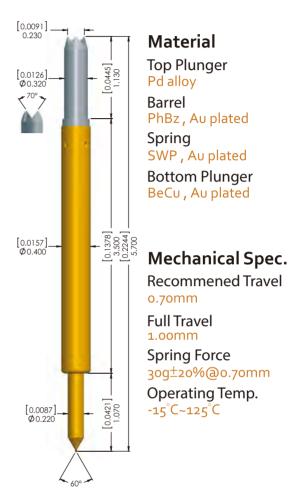
Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance 39.5 Ω Insertion Loss -1dB>20GHz Return Loss -20dB@3GHz Time Delay 25.2 psec Loop Inductance 1 nH Capacitance o.64 pF

Unit:mm; [ ]:in

#### PE1-038EP40-01A0



#### PE3-040BF34-01A0



#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance 42Ω Insertion Loss -1dB>20GHz Return Loss -2odB@3.82GHz Time Delay 29.9 psec Loop Inductance 1.26 nH Capacitance 0.71pF

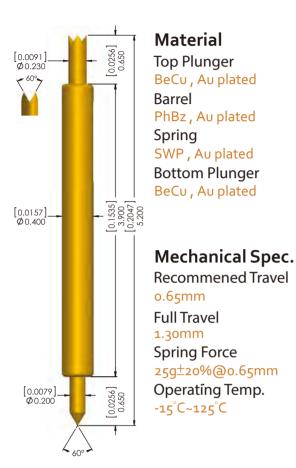
#### **Electrical Spec.**



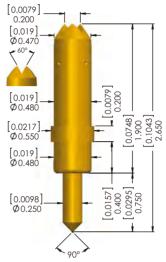
Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $38.29 \Omega$ Insertion Loss 1dB>20GHz Return Loss -20dB@2.16GHz Time Delay 27.95 psec Loop Inductance 1.07 nH Capacitance o.73 pF

Unit:mm; [ ]:in

#### DE1-040BF39-030



#### DE4-048EF17-01F0



# Material

Top Plunger BeCu, Au plated Barrel Brass, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 

o.50mm

**Full Travel** o.6omm Spring Force 27.5g±20%@0.50mm Operating Temp. -15°C~125°C

#### Electrical Spec. Pitch: 0.5mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $36.58\Omega$ Insertion Loss -1dB@15.1GHz Return Loss -20dB@1.99GHz Time Delay 25.97 psec Loop Inductance o.95nH Capacitance 0.71pF

#### Electrical Spec.

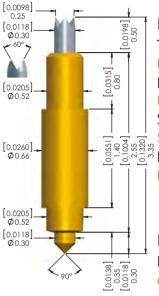


Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $36.5 \Omega$ Insertion Loss -1dB>20 GHz Return Loss -2odB@3.54GHz Time Delay 14.2 psec Loop Inductance o.52nH Capacitance 0.39 pF

# **Probe Specifications**

Unit:mm; [ ]:in

#### PE2-050EF25-01F0



#### Material

Top Plunger
Pd alloy
Barrel
PhBz , Au plated
Spring
SUS , Au plated
Bottom Plunger
BeCu , Au plated

## Mechanical Spec.

Recommened Travel

0.45mm

Full Travel o.6omm

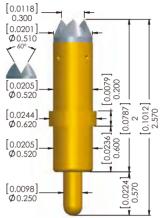
**Spring Force** 

30g±20%@0.45mm

Operating Temp.

-55°C~150°C

#### PE4-052DF17-01A0



#### Material

Top Plunger
Pd alloy
Barrel
PhBz, Au plated
Spring
SWP, Au plated
Bottom Plunger
BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 

o.40mm

Full Travel o.6omm Spring Force

35g±20%@0.40mm

Operating Temp.

-15°C~125°C

# Electrical Spec. Pitch: 0.8mm Socket Material: Peek 1000



Current Rating 1A continuous
Contact Resistance <175m $\Omega(AVG)$ 

Characteristic Impedance 34.8Ω

Insertion Loss 1dB>20GHz
Return Loss -20dB@2.25GHz

Time Delay 19.8psec Loop Inductance 0.69nH

Capacitance 0.57pF

#### **Electrical Spec.**



Pitch: 0.8mm Socket Material: Peek 1000

Current Rating 1A continuous

Contact Resistance <75mΩ(AVG)

Characteristic Impedance  $_{38.7} \Omega$ 

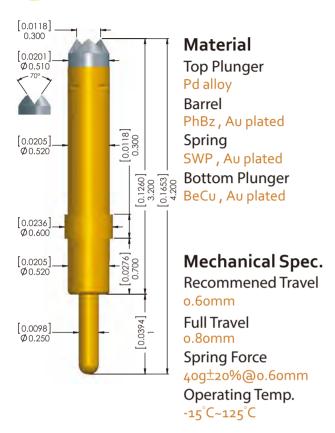
Insertion Loss -1dB>20GHz Return Loss -2odB@4.45GHz

Time Delay 15.4 psec Loop Inductance 0.6 nH Capacitance 0.4 pF

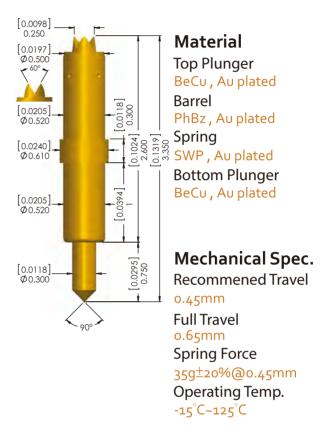
# **Probe Specifications**

Unit:mm; [ ]:in

#### PE4-052DF28-01F0



#### DE4-052EF23-02F0



#### Electrical Spec. Pitch: o.8mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 41.8Ω Insertion Loss -1dB@15.08GHz Return Loss -20dB@3.29GHz Time Delay 23.8 psec Loop Inductance 1nH Capacitance 0.57pF

#### Electrical Spec.





Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $41.5\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@3.45GHz Time Delay 19.9 psec Loop Inductance 0.83 nH Capacitance 0.48 pF

# **Probe Specifications**

Unit:mm; [ ]:in

#### PE4-056DF20-02F0

# [0.0213] Ø0.540 [0.0220] Ø0.560 [0.0256] Ø0.650 [0.0220] Ø0.560 BeCu, Au plated [0.0118] Ø0.300

#### Material

Top Plunger Pd alloy Barrel Brass, Au plated ୍ରିଞ୍ଜ Spring SWP , Au plated **Bottom Plunger** 

#### Mechanical Spec.

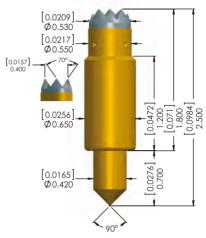
Recommened Travel

o.50mm

-15°C~125°C

**Full Travel** o.70mm **Spring Force** 35g±20%@0.50mm Operating Temp.

#### PE4-065EW15-01A0



#### Material

Top Plunger Pd alloy Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 

o.50mm **Full Travel** o.70mm

**Spring Force** 32g±20%@0.50mm

Operating Temp.

-15°C~125°C

#### Electrical Spec. Pitch: o.8mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $32.68\Omega$ Insertion Loss -1dB@17.48GHz Return Loss -20dB@1.93GHz Time Delay 19.28 psec Loop Inductance o.63nH Capacitance o.59pF

#### Electrical Spec.

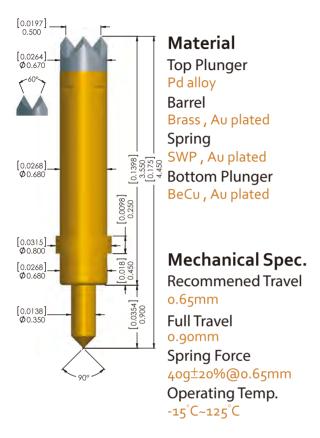


Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $29 \Omega$ Insertion Loss -1dB@10.3GHz Return Loss -2odB@1.79GHz Time Delay 16 psec Loop Inductance 0.47 nH Capacitance 0.55 pF

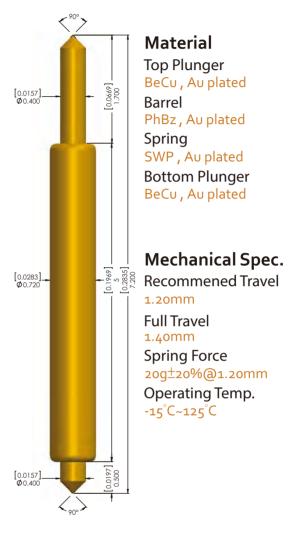
Unit:mm; [ ]:in

C.C.P. Contact Probes Co., Ltd.

#### PE4-068EP35-01F0



#### DE1-072EE50-01A0



#### Electrical Spec. Pitch: 1.0mm Socket Material: Peek 1000



Current Rating 2A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 37.53 Ω Insertion Loss -1dB@11.91GHz Return Loss -20dB@2.19GHz Time Delay 26.65 psec Loop Inductance 1 nH Capacitance 0.71 pF

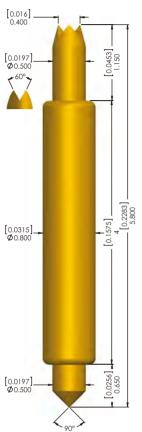
#### Electrical Spec.



Current Rating 1A continuous Contact Resistance <175m $\Omega(AVG)$ Characteristic Impedance  $40.7 \Omega$ Insertion Loss -1dB@13.9GHz Return Loss -20dB@2.37GHz Time Delay 38.7 psec Loop Inductance 1.58 nH Capacitance 0.95 pF

Unit:mm; [ ]:in

#### DE1-080BF40-010

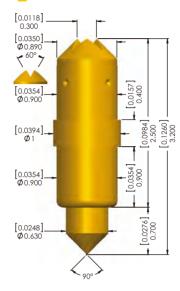


# Material Top Plunger BeCu, Au plated Barrel PhBz, Au plated Spring SWP, Au plated Bottom Plunger

BeCu, Au plated

Mechanical Spec.
Recommened Travel
o.70mm
Full Travel
1.05mm
Spring Force
30g±20%@0.70mm
Operating Temp.
-15°C~125°C

#### DE4-090EF25-02F0



# Material Top Plunger BeCu, Au plated Barrel Brass, Au plated Spring SUS, Au plated Bottom Plunger BeCu, Au plated

Mechanical Spec.
Recommened Travel
0.50mm
Full Travel
0.70mm
Spring Force
30g±20%@0.50mm
Operating Temp.
-55°C~150°C

# Electrical Spec. Pitch: 1.0mm Socket Material: Peek 1000



Current Rating  $_3A$  continuous Contact Resistance  $<175m\Omega(AVG)$  Characteristic Impedance  $_{33.9}\Omega$  Insertion Loss -1dB@12GHz Return Loss -2odB@1.22GHz Time Delay  $_{33.6}$  psec Loop Inductance  $_{1.14nH}$  Capacitance  $_{0.99pF}$ 

# Electrical Spec. Pitch: 1.27mm Socket Material: Peek 1000



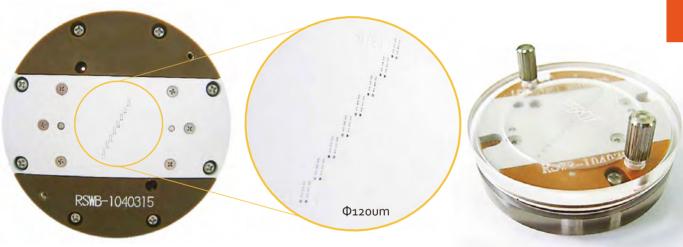
Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$  Characteristic Impedance  $34.6\,\Omega$  Insertion Loss -1dB@17.27GHz Return Loss -2odB@2.16GHz Time Delay  $20.4\,psec$  Loop Inductance  $0.71\,nH$  Capacitance  $0.59\,pF$ 



# **Wafer-Level CSP Test**

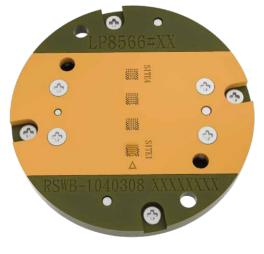
With the massive growth of WLCSP in the semiconductor market, C.C.P. has designed over 30 different kinds of probe heads to meet the demand of the market. A pogo pin design improves the durability of the probe head. Additionally, coplanarity errors induced by differently sized solder balls can be avoided by our pogo pins which have a working travel designed for 250um. We offer a wide variety of head types to meet our client's needs.

# Design Concept



8 balls, pitch 0.5mm

C.CP employs a combination of industry-leading high precision machines from renowned manufacturers as well as custom made equipment. This allows us to drill holes smaller than  $\Phi$  60µm.

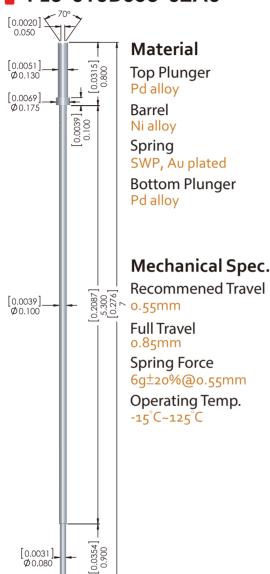


36 balls, pitch 0.4mm

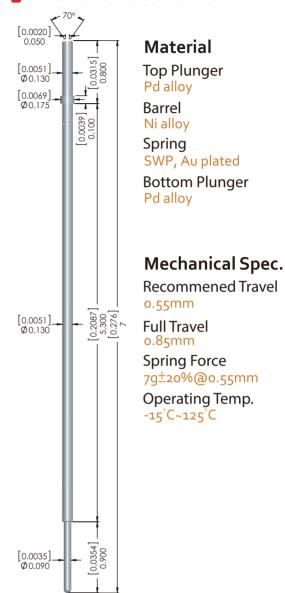
Probe Head	Specification
Min. Pitch	0.1 <sub>5</sub> mm
Max. Site Counts	32 sites
Top Housing Material	Photoveel® /VESPEL®SCP5000
Mounting Plate Material	Torlon® 5530
Bottom Housing Material	VESPEL®SCP5000
Life Time (Pin)	>300,000

Unit:mm; [ ]:in

#### PE3-010DS53-02A0



#### PE3-013DS53-01F0



#### **Electrical Spec.**



Current Rating 0.2A continuous
Contact Resistance <500mΩ(AVG)
Characteristic Impedance 91.77 Ω
Insertion Loss -1dB@3.76GHz
Return Loss -20dB@0.72GHz
Time Delay 34.87 psec
Loop Inductance 3.2 nH
Capacitance 0.38 pF

#### **Electrical Spec.**





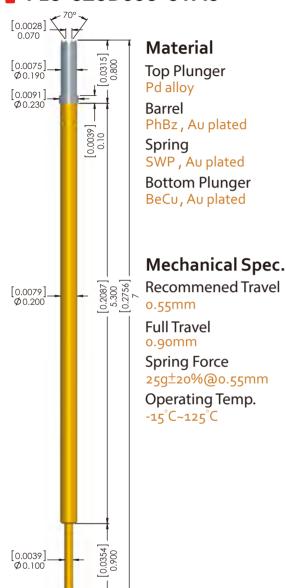
Current Rating 0.4 A continuous Contact Resistance  $<500m\Omega(AVG)$  Characteristic Impedance  $91.3\Omega$  Insertion Loss  $-1dB@1.47\,GHz$  Return Loss  $-20dB@0.43\,GHz$  Time Delay  $42.9\,psec$ 

Loop Inductance 3.92 nH Capacitance 0.47 pF

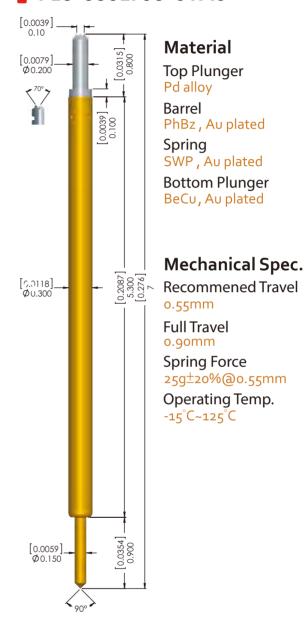


Unit:mm; [ ]:in

#### PE3-020DS53-01A0



#### PE3-030EF53-01A0



# Electrical Spec. Pitch: 0.4mm Socket Material: Peek 1000



Current Rating 0.6A continuous Contact Resistance  $<300 \text{m}\Omega(\text{AVG})$  Characteristic Impedance  $66.62\,\Omega$  Insertion Loss -1dB>20GHz Return Loss -20dB@1.84GHz Time Delay 37.97 psec Loop Inductance 2.32 nH Capacitance 0.57 pF

# Electrical Spec. Pitch: 0.4mm Socket Material: Peek 1000



Current Rating  $^{1A}$  continuous Contact Resistance  $^{175m}\Omega(AVG)$  Characteristic Impedance  $^{42\cdot3}\Omega$  Insertion Loss  $^{-1dB}$   $^{20}$  GHz Return Loss  $^{-20dB}$   $^{3}$  GHz Time Delay  $^{34\cdot7}$  psec Loop Inductance  $^{1.47}$  Capacitance  $^{0.82}$  pF

# **High Current Solutions**

C.C.P. offers a patented solution for high current pogo pin testers that can be used in a variety of applications such as EV Battery testing or other industrial applications. The design is customizable and can be fitted to your specific requirements. The design offers a much more reliable current flow and reduces the wear on the tester significantly.

# Design Concept

Double-Ended High Current Probe for IC Testing



Current Path of...
Normal pin: Blue line

High current pin: Red line

Taiwan Patent No. M453149

Generally, the current runs from the bottom plunger through the barrel wall to the top plunger. Due to that, the contact resistance between the wall and plunger will increase gradually. This can cause the spring to burn and lead to a failure at higher currents. The straight plunger in the center of the high current pin allows the current to take a direct route, to the top plunger and in consequences avoids flowing through the spring during testing.

Single High Current Pin for Lithium Battery Testing



CCP developed a special design which is different from standard testing pins to improve the current carrying capabilities of our high current pin.

Coaxial High Current Pin for Lithium Battery Testing



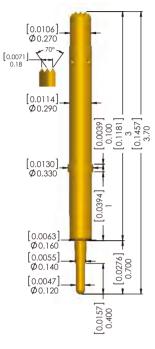
This coaxial high current pin combines a sensor pin with a current test pin in one probe design. The one-piece design of the current test pin improves the electrical resistance significantly.



# Probe Specifications (IC Testing Probe)

Unit:mm; [ ]:in

#### DE4-029DW25-01A0



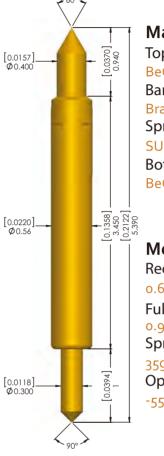
# Material Top Plunger BeCu, Au plated Barrel PhBz, Au plated Spring SUS, Au plated Bottom Plunger

BeCu, Au plated

Mechanical Spec.
Recommened Travel
o.4omm
Full Travel
o.7omm
Spring Force
25g±20%@o.4omm
Operating Temp.

-55°C~150°C

#### DE3-056BE34-01A0



# Material Top Plunger BeCu , Au plated Barrel Brass , Au plated Spring SUS , Au plated Bottom Plunger BeCu , Au plated

Mechanical Spec.
Recommened Travel
o.67mm
Full Travel
o.95mm
Spring Force
35g±20%@o.67mm
Operating Temp.
-55°C~150°C

#### Electrical Spec.



Current Rating 3A continuous Contact Resistance  $<75\text{m}\Omega(\text{AVG})$ Characteristic Impedance  $52.7\,\Omega$ Insertion Loss -1dB>20GHzReturn Loss -20dB@10GHzTime Delay  $18.97\,\text{psec}$ Loop Inductance  $1.00\,\text{nH}$ Capacitance  $0.36\,\text{pF}$ 

#### Electrical Spec.



Current Rating 5A continuous Contact Resistance  $<75m\Omega(AVG)$  Characteristic Impedance  $32.1\Omega$  Insertion Loss -1dB@6.27GHz Return Loss -2odB@1.2GHz Time Delay 29.5 psec Loop Inductance 0.95nH Capacitance 0.92pF

# Probe Specifications (Battery Testing Probe)

Unit:mm; [ ]:in

#### H101001M1

# [0.1378] \$\phi\_{3.500}\$ [0.1102] \$\phi\_{2.800}\$ [0.1575] \$\phi\_{4}\$ [0.1437] \$\phi\_{3.650}\$ [0.1299] \$\phi\_{3.300}\$

#### Material

Plunger
BeCu, Au plated
Barrol

Barrel Brass, Au plated Spring SUS, Au plated

# Mechanical Spec.

Recommened Travel

2.30mm

Full Travel 3.5mm

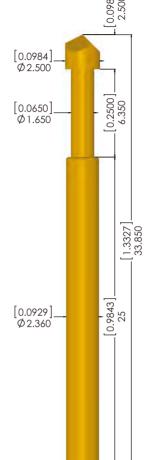
Spring Force 2509±20%@2.3mm

Operating Temp. -55°C~150°C

**Current Rating** 

10 A

### S-11T1-2545G



#### Material

Plunger BeCu , Au plated Barrel

Brass , Au plated Spring

SUS , Au plated

#### Mechanical Spec.

Recommened Travel 4.20mm

Full Travel 6.35mm

Spring Force 450g±20%@4.20mm

Operating Temp. -55°C~150°C

**Current Rating** 

6 A



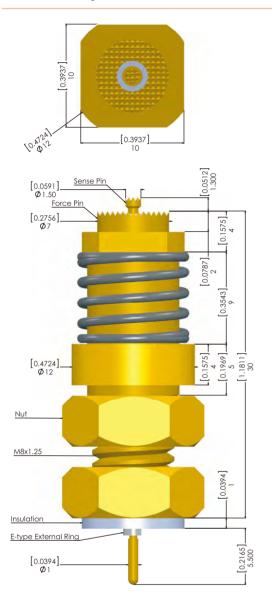
#### **Application Demonstration**

Probes touch the PCB to close the circuits and activate the lithium battery.



# Probe Specifications (Battery Testing Probe)

Unit:mm; [ ]:in



#### H050002M0

#### Material

<u>Sense Pin</u> Plunger BeCu , Au plated Barrel

PhBz , Au plated Spring

SUS , Au plated Force Pin

Plunger BeCu , Au plated

Barrel

Brass, Au plated Spring

SUS , Au plated *Nut* 

BeCu, Au plated Insulation Teflon

#### Mechanical Spec.

Sense Pin

Recommened Travel

1.00mm

Full Travel

**Spring Force** 

90g±20%@1.00mm

Force Pin

Recommened Travel 4.00mm

Full Travel

6.oomm

**Spring Force** 

700g±20%@4.00mm

#### **Current Rating**

50 A



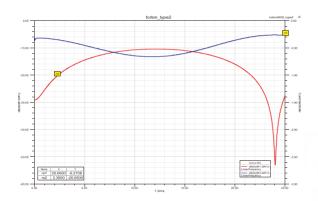
## Application Demonstration

We are able to customize our probes to meet your current carrying requirements. Several patented designs and proprietary, industry leading plating technologies will offer you the right solution for your application.

# **High Frequency Solutions**

High frequency testing is mostly used for radio-frequency channels and wide-band transmission applications. The signal pin can be customized according to the electrical characteristics and testing environments of the client. For IC testing, we usually recommend ultra-short pins, coaxial probes, and PCRs to accommodate the different types of ICs.

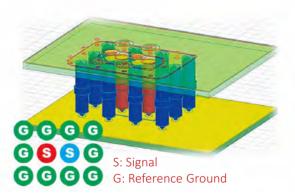
# Design Concept



We have the ability to simulate 3D electromagnetic performance as well as S-parameters, inductance and impedance and by that improving SI characteristics.

#### Performance Simulation

CCP utilizes HFSS to simulate the pin performance in the sockets. This allows us to choose the best pin before designing a customized sockets.

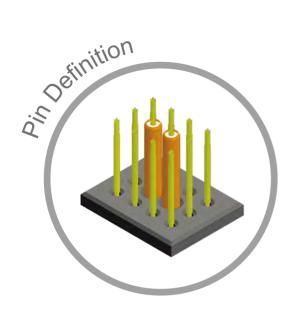




CCP has a dedicate high frequency lab that uses TDR, network analyzers and RF probe stations to measure the socket / pins actual performance and therby verifying the simulation results. These are all indispensable equipments for developing new high-class products.



# Probe Specifications (Coaxial Probe)





#### **Pin Definition**



Signal Probe



**Ground Probe** 



## **Application**

Feature:

High Speed / High Frequency

DUT:

Bluetooth / GPS / LTE / Wireless IC / 5G

Packaging:

BGA / CSP / QFN / QFP

### **Specification**

Insertion Loss:

-1dB @ >50 GHz

Return Loss:

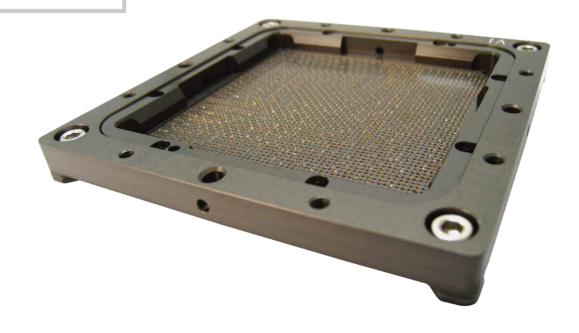
-20dB @ >30 GHz

Impedance:

50 Ohm

Pitch:

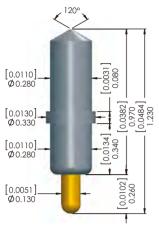
0.65~1.00 mm



# Probe Specifications (IC Test Probe)

Unit:mm; [ ]:in

#### PE4-028DE09-01A0



#### **Material**

Barrel Pd alloy Spring SUS, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

**Recommened Travel** 

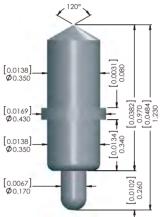
0.18mm

**Full Travel** 0.23mm

**Spring Force** 15g±20%@0.18mm

Operating Temp. -55°C~150°C

## PE4-035DE09-01H0



#### Material

Barrel Pd alloy Spring SUS, Au plated **Bottom Plunger** Pd alloy

#### Mechanical Spec.

**Recommened Travel** 

0.18mm

Full Travel 0.23mm **Spring Force** 14g±20%@0.18mm Operating Temp.

-55°C~150°C

#### **Electrical Spec.**



Pitch: 0.5mm Socket Material: Peek 1000 Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 48.9 Ω Insertion Loss -1dB>20GHz Return Loss -20dB>20GHz Time Delay 7.3 psec Loop Inductance o.36 nH Capacitance 0.15 pF

#### **Electrical Spec.**





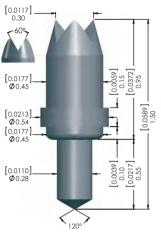
Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance  $37.4\Omega$ Insertion Loss -1dB>20GHz Return Loss -2odB@7.62GHz Time Delay 7.48 psec Loop Inductance 0.28 nH Capacitance 0.2 pF



# Probe Specifications (IC Test Probe)

Unit:mm; [ ]:in

#### PE4-045EF09-01A0



#### Material

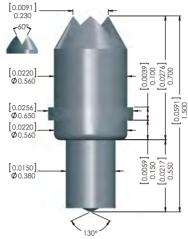
Barrel Pd alloy Spring SUS, Au plated Bottom plunger Pd allov

#### Mechanical Spec.

Recommended travel

o.4omm Full travel 0.55mm Spring force 30g±20%@0.40mm Operating Temp. -55°C~150°C

### PE4-056EF09-01H0



#### Material

Barrel Pd alloy Spring SUS, Au plated Bottom plunger Pd allov

#### Mechanical Spec.

Recommended travel o.4omm Full travel 0.55mm Spring force 31g±20%@0.40mm Operating Temp. -55°C~150°C

#### Electrical Spec.

Capacitance 0.24 pF



Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance 35.9 Ω Insertion Loss -1dB>20GHz Return Loss -2odB@5.54GHz Time Delay 8.6 psec Loop Inductance 0.31 nH

### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance  $^{29.7}\Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@ 2.9GHz Time Delay 10.4 psec Loop Inductance 0.31nH Capacitance 0.35 pF



# **Kelvin Contact Solutions**

The term Kelvin Contact is derived from the English physicist Lord Kelvin who invented the Kelvin Bridge in 1861. The Kelvin Bridge is used to measure unknown electrical resistors below  $1\Omega$  and is a modification of the Wheatstone bridge. The Kelvin contact solution by C.C.P. is using one of the pins to measure the current while the other is adjusting the applied voltage. As with all our products our engineers will adjust the product according to your specific needs.

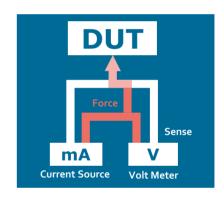
0.07~0.10mm

# Design Concept

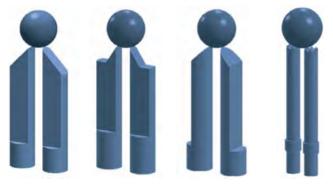
#### Kelvin Contact

Kelvin Contact is mostly used to test specific electrical signals, as well as be the route of current bypass when testing. C.C.P. innovated several types of kelvin pins to meet market demands.

Available in 70um~100um kelvin gap, allows precise contacts to balls / pads.



## Different type of tip for various application



Blade Tip Ladder Tip Half Moon Tip Crown Tip

Kelvin Socket	Specification			
IC Type	QFN,QFP,BGA			
IC Size	2X2~20X20 mm²			
Min. Pitch	o.3omm			
Life Time (Pin)	>200,000			

Blade: Common tip type for kelvin testing Ladder: Similar with blade type but more accurate positioning Half Moon: Mostly applied in QFN, QFP

Crown: No need to take the direction into account when manufacturing the socket and inserting the pins as each claw can prick the testing area.



Unit:mm; [ ]:in

## PE3-015DL38-01A0

# [0.0035] 0.090 [0.0059] 0.150 [0.0043] 0.110 [0.0043] 0.000 [0.0043]

#### Material

Top Plunger
Pd alloy
Barrel
Ni alloy
Spring
SUS
Bottom Plunger
Pd alloy

#### Mechanical Spec.

Recommened Travel

o.4omm

Full Travel 0.70mm

**Spring Force** 

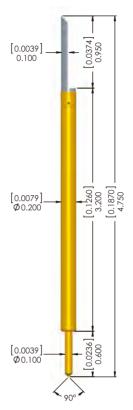
20g±20%@0.40mm Operating Temp.

-55°C~150°C

#### **Electrical Spec.**

Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ 

#### PE3-020EL31-01A0



#### Material

Top Plunger Pd alloy

Barrel

PhBz , Au plated

Spring

 $\ensuremath{\mathsf{SWP}}$  ,  $\ensuremath{\mathsf{Au}}$  plated

Bottom Plunger BeCu, Au plated

#### Mechanical Spec.

Recommened Travel

o.30mm

Full Travel

o.50mm

Spring Force

10g±20%@0.30mm

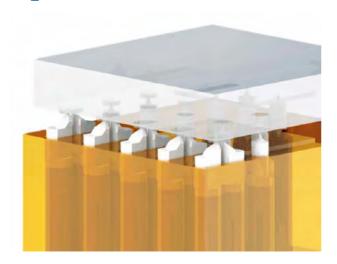
Operating Temp.

-15°C~125°C

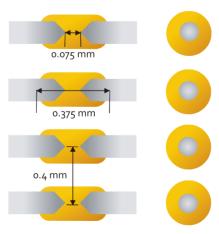
### **Electrical Spec.**

Current Rating 2A continuous Contact Resistance  $<75m\Omega(AVG)$ 

### Half Moon Kelvin Socket Example

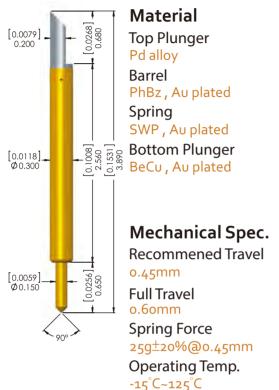


#### **Pin Array**



Unit:mm; [ ]:in

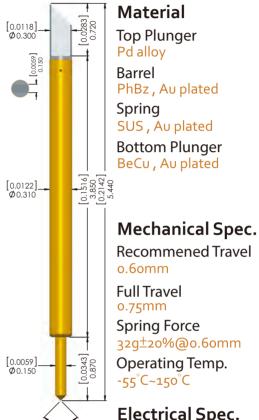
#### PE3-030EL25-01A0



#### **Electrical Spec.**

Current Rating 3A continuous Contact Resistance <75m $\Omega(AVG)$ 

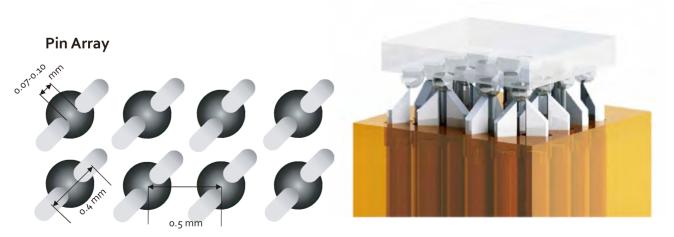
# PE3-031EL38-01A0



### **Electrical Spec.**

Current Rating 3A continuous Contact Resistance  $<75m\Omega(AVG)$ 

### Blade Kelvin Socket Example





# **Memory Test Solutions**

Memory ICs are a core component of nearly every electronic device. Memory ICs are usually categorized in volatile and non-volatile memory where volatile memory keeps its stored information when the power cycle is interrupted and volatile memory needs a constant power supply to retain its data. Most memory modules have a standardized format that can be tested with standardized test-pins. C.C.P. offers testing solutions for all common formats (DDR, Flash, eMCP, etc.) as well as customized testing solutions for your individual needs.

# **Design Concepts**



Housing	Material	Housing	Spec.
Injection molding	PES	Min. Pitch	o.4mm



Manual DDR2/3	Testing	Module
Single	Side	



Manual DDR3 Testing Module
Double Side

Manual DDR2/3 T	Testing Module
-----------------	----------------

Max. Site Amount

Transmission Rate (MT/s)

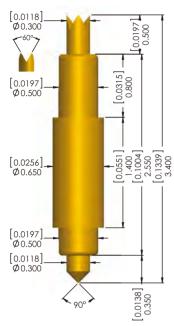
Spec.
8~16 (Single side/ Double side)

200MHz~1866MHz

Unit:mm; [ ]:in

#### DE2-050EF25-120





# Material

Top Plunger BeCu, Au plated Barrel Brass, Au plated Spring SUS, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec. **Recommened Travel**

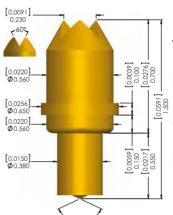
o.4omm **Full Travel** o.6omm

Spring Force 35g±20%@0.40mm Operating Temp.

-55°C~150°C

#### DE4-056EF09-03F0





# Material

Top Plunger BeCu, Au plated Barrel SUS, Au plated Spring BeCu, Au plated **Bottom Plunger** 

#### Mechanical Spec.

Recommened Travel

o.4omm

**Full Travel** o.50mm

Spring Force

30g±20%@0.40mm

Operating Temp.

-55°C~150°C

#### **Electrical Spec.** Pitch: o.8mm Socket Material:



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $37\Omega$ Insertion Loss -1dB@18.6GHz Return Loss -2odB@2.69GHz Time Delay 20.4 psec Loop Inductance 0.76 nH Capacitance 0.55 pF

#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance  $36.16 \Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@5.11GHz Time Delay 9.4 psec Loop Inductance o.34nH

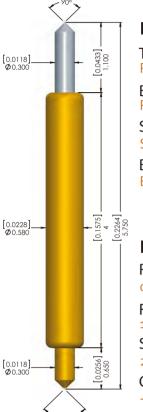
Capacitance 0.26pF



Unit:mm; [ ]:in

## PE1-058EE40-01A0





#### **Material**

Top Plunger Pd alloy

Barrel PhBz , Au plated

Spring

SUS, Au plated

Bottom Plunger BeCu , Au plated

#### Mechanical Spec.

Recommened Travel o.8omm

Full Travel

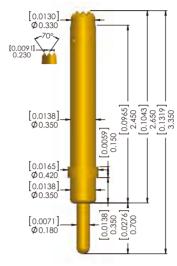
Spring Force

28g±20%@0.80mm

Operating Temp. -55°C~150°C

#### DE4-035DH24-01A0





Material
Top Plunger
BeCu, Au plated
Barrel
PhBz, Au plated
Spring
SWP, Au plated
Bottom Plunger
BeCu, Au plated

#### Mechanical Spec.

Recommened Travel

o.50mm

Full Travel o.70mm

Spring Force

27g±20%@0.50mm

Operating Temp.

-15°C~125°C

# Electrical Spec. Pitch: 0.8mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$  Characteristic Impedance  $41.2\Omega$  Insertion Loss -1dB>20GHz

Return Loss -2odB@ 2.56GHz

Time Delay 32.2 psec Loop Inductance 1.33 nH Capacitance 0.78 pF

#### **Electrical Spec.**



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$  Characteristic Impedance  $40.06\Omega$  Insertion Loss -1dB>20GHz

Return Loss -2odB@4.5GHz Time Delay 17.22 psec

Loop Inductance o.69 nH

Capacitance o.43 pF



# **Burn In Test**

The Burn-In test will expose the DUT (device under test) to harsh conditions: 150°C; relative humidity (RH): 85 rh; current rating: 1A continuous for 1000 hrs. In order to withstand conditions like that, C.C.P. modifies the plating material and core material. C.C.P. splits the socket into two parts: The standard part and the machining part. The standard part is manufactured by insert molding and holds the machining part which is customized according to the customers' IC design and made by CNC. The pins for the burn-in solution use a special material (WJ3) that shows an exceptional hardness and is able to withstand the demanding conditions posed by the Burn-In test.

# Design Concept



Burn in Socket	Specification			
IC Size	<15X15 mm²			
Min. Pitch	0.3			
Body Material	PES (Black)			
Housing Material	Ultem2300			
Operating Temperature	-55°C~180°C			

Pogo Type Burn-in Socket

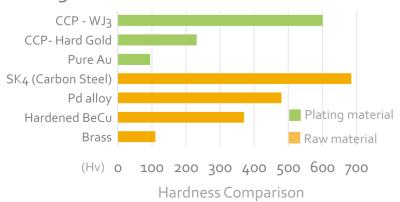
C.C.P. splits the socket into a standard part and a machining part. The standard part is processed by insert molding while the machining part is manufactured by CNC according to IC's size. This shortens the development time and reduces the mold tooling cost. C.C.P. can customize the sockets according to your needs.





Customized part Standard Part Manufactured according to IC size

### Plating / Raw Material

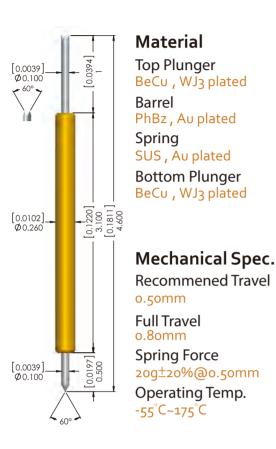


Commonly used in burn in test solution, WJ3 is a special plating material developed by C.C.P. and usually plated on the DUT side plunger. Besides high hardness, WJ3 is able to perform steadily in severe testing environments that reach 150°C for 1000 hours possibly even for 3000 hours.

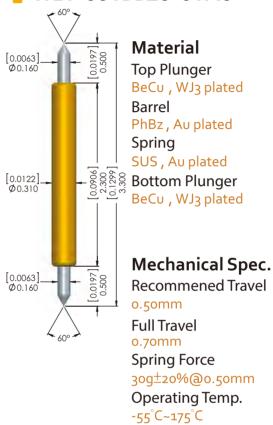


Unit:mm; [ ]:in

#### WE1-026EF31-01A0



#### WE1-031BB23-01A0



#### **Electrical Spec.**

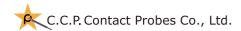
Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $57\Omega$ Insertion Loss -1dB>20GHz Return Loss -20dB@8.38GHz Time Delay 23.4 psec Loop Inductance 1.34 nH Capacitance 0.41pF

### **Electrical Spec.**



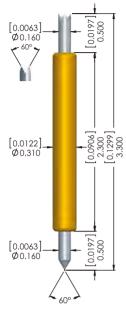


Current Rating 1.5A continuous Contact Resistance <175m $\Omega(AVG)$ Characteristic Impedance  $40.8 \Omega$ Insertion Loss -1dB>20 GHz Return Loss -2odB@ 5.3 GHz Time Delay 15.9 psec Loop Inductance o.65 nH Capacitance 0.39 pF



Unit:mm; [ ]:in

#### WE1-031BF23-01A0



#### Material

Top Plunger
BeCu , WJ3 plated
Barrel
PhBz , Au plated
Spring
SUS , Au plated
Bottom Plunger
BeCu , WJ3 plated

## Mechanical Spec.

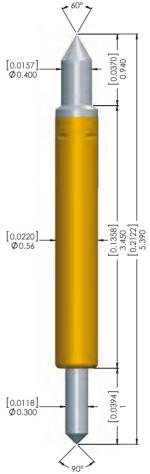
Recommened Travel 0.50mm

Full Travel
0.70mm

Spring Force
30g±20%@0.50mm

Operating Temp.
-55°C~175°C

#### WE3-056BE34-02A0



#### Material

Top Plunger
BeCu, WJ3 plated
Barrel
Brass, Au plated
Spring
SUS, Au plated
Bottom Plunger
BeCu, WJ3 plated

#### Mechanical Spec.

Recommened Travel o.67mm Full Travel

o.gomm Spring Force 35g±20%@o.67mm

Operating Temp. -55°C~175°C

#### Electrical Spec.



Current Rating 1.5A continuous Contact Resistance  $<175 m\Omega(AVG)$  Characteristic Impedance  $33.72\Omega$  Insertion Loss -1dB@12.51GHz Return Loss -2odB@2.49GHz Time Delay 17.2 psec Loop Inductance 0.58 nH Capacitance 0.51 pF

#### **Electrical Spec.**



Current Rating 5A continuous Contact Resistance  $<75\text{m}\Omega(\text{AVG})$  Characteristic Impedance  $32.1\Omega$  Insertion Loss -1dB@7GHz Return Loss -2odB@1.19GHz Time Delay  $29.5\,\text{psec}$  Loop Inductance 0.95nH Capacitance  $0.92\,\text{pF}$ 



# Fin Pitch Conn. / FPC Test

A board to board connection requires fine-pitch pogo sockets to achieve the required accuracy. Pogo-Pin testing solutions have a significantly increased lifetime with more than 300,000 touchdowns. The excellent connectivity reduces the coplanarity error that occurs with traditional testing pins and results in improved efficiency of the testing procedures. C.C.P. has developed different kinds of testing pins that can be custo-mized according to the customer's needs.

# Design Concept



Single-site pogo socket Pitch: 0.4mm



Fine Pitch Connector
Device under Test



Dual-site pogo socket with fine pitch connector (DUT)

### Clip Pogo Socket

Clip pogo socket can hold the gold finger part on a PCB or an FPC. This solution is especially efficient and easy for PCB/FPC testing.

Pogo Socket Parts	Specification
Min. Pitch	o.35mm
Lid Material	Acrylic/ Aluminum
Floating Plate/ Top, Bottom Housing Material	Peek Ceramic
<b>Mounting Plate Material</b>	Aluminum
Life Time	30,000





Device under Test



#### DE1-030DF40-05A0

#### [0.0059] \$\phi\_{0.150}\$ \$\phi\_{0.150}\$ \$\phi\_{0.300}\$ \$\phi\_{0.150}\$ \$\phi\_{0.300}\$ \$\ph

#### **Material**

Top Plunger SK4, Au plated Barrel PhBz, Au plated Spring SWP, Au plated Bottom Plunger BeCu, WJ3 plated

#### Mechanical Spec.

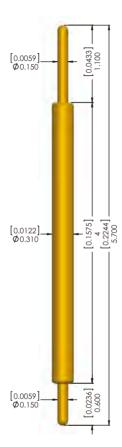
Recommened Travel o.50mm

Full Travel

Spring Force 25g±20%@0.50mm

Operating Temp.  $-15^{\circ}\text{C} \sim 125^{\circ}\text{C}$ 

#### DE1-031DD40-01W1



#### Material

Top Plunger SK4, Au plated Barrel PhBz, Au plated Spring SWP, Au plated Bottom Plunger SK4, Au plated

#### Mechanical Spec.

Recommened Travel

o.8omm

Full Travel

1.00mm

Spring Force 25q±20%@0.80mm

Operating Temp.

-15°C~125°C

# Electrical Spec. Pitch: 0.4mm Socket Material: Peek 1000

Capacitance 0.63 pF



Current Rating 1A continuous Contact Resistance <175 $m\Omega$ (AVG) Characteristic Impedance 44.8 $\Omega$  Insertion Loss -1dB>20GHz Return Loss -2odB@4.5GHz Time Delay 28.2 psec Loop Inductance 1.27nH

#### **Electrical Spec.**



Pitch: 0.4mm Socket Material: Peek 1000

Current Rating 1A continuous

Contact Resistance <175 $m\Omega$ (AVG) Characteristic Impedance 42.54 $\Omega$ Insertion Loss -1dB@18.82GHz

Return Loss -20dB@3.41GHz

Time Delay 26.8 psec

Loop Inductance 1.14 nH

Capacitance 0.63 pF



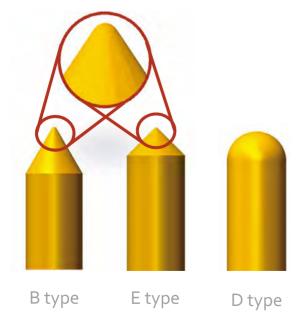
# **Panel Test**

Most electronic devices use displays to interact with the user. Those displays are often fragile which requires appropriate testing solutions. Pogo pins are especially suitable for this type of application due to their customized tip, which protects the DUT from scratches.

## Design Concept



Panel Pin Housing



#### Panel Test Housing

The housing is installed on a test head which contacts the panel directly. To protect the panel from damage, the head is rounded which prevents scratching of the panel surface.

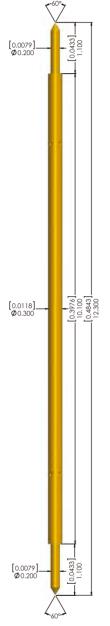
Panel Pin Housing	Specification
Min. Pitch	o.45 mm
Panel Size	50"~85"
<b>Housing Material</b>	Peek
Life Time (Pin)	>200,000

## Panel Pin Head Type

A conical tip is able to puncture oxide layers and has a low chance to leave scratches on the display. We usually recommend the D type for panel tests, to eliminate the chance of scratches.

Unit:mm; [ ]:in

#### DE1-030BB10-01A0



#### **Material**

Top Plunger Sk4, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** Sk4, Au plated

#### Mechanical Spec.

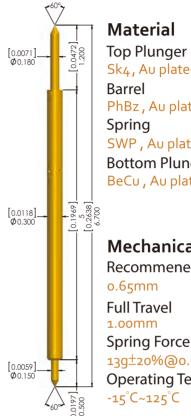
Recommened Travel

1.25mm

**Full Travel** 1.90mm Spring Force 20g±20%@1.25mm Operating Temp.

-15°C~125°C

#### DE1-030BB50-01A0



#### Material

Top Plunger Sk4, Au plated Barrel PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated

#### Mechanical Spec.

Recommened Travel

0.65mm

**Full Travel** 1.00mm

13q±20%@0.65mm

Operating Temp.

-15°C~125°C

**Electrical Spec.** Pitch: 0.4mm Socket Material: Peek 1000

Capacitance 1 pF



Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $67\Omega$ Insertion Loss -1dB@3.34GHz Return Loss -2odB@o.87GHz Time Delay 67.01 psec Loop Inductance 4.49 nH

**Electrical Spec.** 



Pitch: 0.4mm Socket Material: Peek 1000

Current Rating 1A continuous Contact Resistance  $<175m\Omega(AVG)$ Characteristic Impedance  $45\Omega$ Insertion Loss -1dB >20GHz Return Loss -2odB@3.35GHz Time Delay 32.8 psec Loop Inductance 1.48 nH Capacitance 0.73 pF

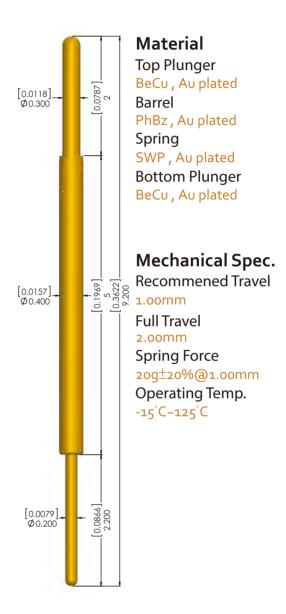


Unit:mm; [ ]:in

#### DE3-031DD50-01A0

## **Material** Top Plunger BeCu, Au plated [0.0091] Ø0.230 PhBz, Au plated Spring SWP, Au plated **Bottom Plunger** BeCu, Au plated Mechanical Spec. 0.2000] 5.080 0.3575] 9.080 [0.0122]. Ø0.310 **Recommened Travel** 1.00mm **Full Travel** 2.00mm **Spring Force** 20q±20%@1.00mm Operating Temp. -15°C~125°C [0.0071] Ø0.180

#### DE3-040DD50-01A0



#### Electrical Spec.



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance 41.54 Ω Insertion Loss -1dB@14.66GHz Return Loss -20dB@2.03GHz Time Delay 42.37 psec Loop Inductance 1.76 nH Capacitance 1.02 pF

#### **Electrical Spec.** Pitch: 0.5mm Socket Material: Peek 1000

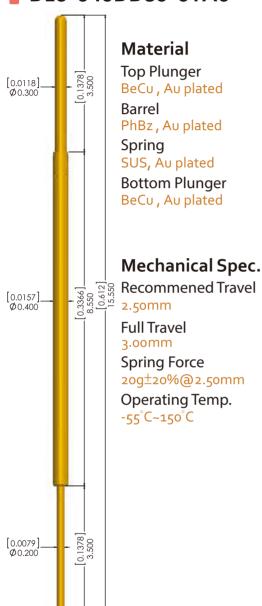


Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $42.13\Omega$ Insertion Loss -1dB@10.93GHz Return Loss -20dB@2.05GHz Time Delay 46.76 psec Loop Inductance 1.97 nH Capacitance 1.11 pF

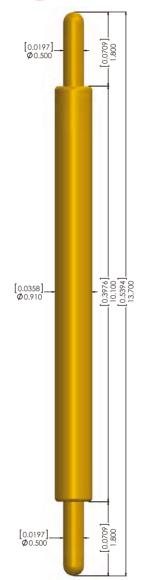


Unit:mm; [ ]:in

#### DE3-040DD85-01A0



#### DE1-091DD10-01A0



#### Top Plunger BeCu , Au plated Barrel PhBz , Au plated

Material

PhBz , Au plated Spring SWP , Au plated Bottom Plunger BeCu , Au plated

#### Mechanical Spec.

**Recommened Travel** 

2.00mm

Full Travel
3.00mm

Spring Force
20g±20%@2.00mm

Operating Temp.
-15°C~125°C

# Electrical Spec. Pitch: 0.5mm Socket Material: Peek 1000



Current Rating 1A continuous Contact Resistance  $<75m\Omega(AVG)$ Characteristic Impedance  $40\Omega$ Insertion Loss -1dB@6.08GHzReturn Loss -20dB@1.06GHzTime Delay 74.8 psec Loop Inductance 3 nH Capacitance 1.87 pF

# Electrical Spec. Pitch: 1.0mm Socket Material: Peek 1000



Current Rating  $^{2A}$  continuous Contact Resistance  $^{175m}\Omega(AVG)$  Characteristic Impedance  $^{24.2}\Omega$  Insertion Loss  $^{-1dB}@1.52\,GHz$  Return Loss  $^{-2odB}@0.28\,GHz$  Time Delay  $^{72.6}$  psec Loop Inductance  $^{1.76}$  nH Capacitance  $^{3}$  PF



# **ATE Connection**

Pogo towers and adapters are usually used to connect a motherboard and a daughterboard in automatic testing equipment. C.C.P. has developed ATE connecting solutions for several years. Testing equipment such as J750 and V93000 are well-established solutions.

# Design Concept

A pogo tower can be customized according to you requirements such as frequency or pitch.



Pogo tower (line)



Pogo tower (ring)



Pogo tower (line)	Specification
Housing Material	FR4
Pitch	2.54
Insertion Loss	-3dB@2.4GHz
Pogo tower (ring)	Specification
Housing Material	FR <sub>4</sub>
Pitch	2.54
Insertion Loss	-3dB@2.4GHz
Pogo cable	Specification
Housing Material	FR4
Pitch	2.54
Insertion Loss	-3dB@2.4GHz
Impedance	50Ω



## Cleaning Tools



Nylon Brush SSP-SSN-906500

Wire Diameter: Φ0.1mm

Size: 2.1 mm\*4.0 mm\*L145 mm



Steel Brush SSP-SSS-SST6SS

Wire Diameter: Φ0.1mm

Size: 3.5mm\*6.5 mm\*L130 mm



Steel Brush SSP-SSS-SST2SS

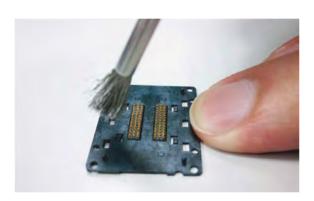
Wire Diameter: Φ0.1mm Size: 2.0 mm\*4.5mm\*L93 mm



Tungsten Steel Brush SSP-BR-TS002-094

Wire Diameter: Φ0.02mm Size: 1.7 mm\*4.2 mm\*L94 mm

# **Probe Cleaning**



Particles can interfere with the test result and decrease the yield rate. Probe cleaning can avoid this situation from happening. We can provide various cleaning tooling for persistent solder splashes or particles on the probe tip.

Slightly brush the probe tip to remove particle or tin on it.



Probe damage level:

Nylon brush

- < Nano Tungsten steel brush
- < Steel Brush (smaller brush size)
- < Steel Brush (bigger brush size)



No Damage

Type 1
Double Active

Type 2
Double Active
W/ Ring

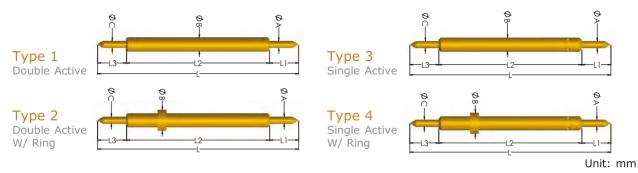
Type 4
Single Active
W/ Ring

Unit: mm

										UII	it: mm
				Barrel	Plunger A	Plunger	Plunger C			Spring Force	
Pitch	P/N	Туре	Length	/Ring OD	Type/ Length	A OD	Type/ Length	COD	Stroke	±20% @Working	Spec (page)
FILCII	F/IN	Type	(L)	(фВ)	(L1)	(фА)	(L3)	(фС)		Stroke	(page)
	PE1-010EE20-01A0	1	3.00	0.10	Conical/ 0.40	0.045	Conical/ 0.40	0.045	0.35	79	6
0.2	PE3-010DS53-02A0	3	7.00	0.175	Serrated/ 0.70	0.13	Round/ 0.90	0.08	0.55	6g	28
	PE3-013DS53-01F0	3	7.00	0.175	Serrated/ 0.70	0.13	Round/ 0.90	0.09	0.55	6g	28
	PE3-015DL38-01A0	3	5.50	0.15	Blade/ o.8o	0.14	Round/ o.8o	0.11	0.40	20g	39
	PE3-020EL31-01A0	3	4.75	0.20	Blade/ 0.95	0.19	Conical/ o.6o	0.10	0.30	10g	39
0.3	DE1-020BE40-01A0	1	5.70	0.20	Conical/ 1.10	0.10	Conical/ o.6o	0.10	0.60	<b>12</b> g	6
	PE3-020DS53-01A0	3	7.00	0.23	Serrated/ 0.70	0.19	Round/ 0.90	0.10	0.55	25g	29
	DE1-020BE74-010	1	9.70	0.20	Conical/ 1.50	0.12	Conical/ o.8o	0.12	0.80	6g	7
	DE1-025BB10-02A0	1	12.20	0.25	Conical/ 1.10	0.13	Conical/ 1.10	0.13	1.45	3og	7
	PE4-025EF24-01A0	4	3.30	0.32	Crown/ 0.25	0.24	Conical/ 1.10	0.11	0.40	23g	8
	PE3-026DF17-01F0	3	3.00	0.26	Crown/ o.70	0.15	Conical/ 0.50	0.12	0.35	20g	8
	PE3-026BD18-01A0	3	2.87	0.18	Conical/ 0.52	0.18	Round/ 0.50	0.13	0.30	249	9
	PE3-026DF27-01F0	3	4.25	0.26	Crown/ o.6o	0.15	Round/ o.85	0.13	0.40	22g	9
	WE1-026EF31-01A0	1	4.60	0.26	Crown/ 1.00	0.10	Conical/ 0.50	0.10	0.50	20g	45
	DE1-026BE40-01A0	1	5.70	0.26	Conical/ 1.10	0.10	Conical/ o.6o	0.10	0.65	<b>1</b> 4g	10
	DE1-026DF40-02A0	1	5.70	0.26	Crown/ 1.10	0.11	Round/ o.6o	0.11	0.65	18g	10
	DE3-026EF49-01A0	3	7.20	0.26	Crown/ 1.30	0.17	Conical/ 0.90	0.12	0.70	20g	11
	PE4-028DE09-01A0	4	1.23	0.33	-	-	Round/ 0.26	0.13	0.18	<b>1</b> 5g	36
	DE4-029DW25-01A0	4	3.70	0.33	Serrated/ 0.45	0.27	Round/ 0.70	0.12	0.40	25g	31
	DE4-029FF45-01A0	4	6.50	0.34	Crown/ o.75	0.22	Crown/ 1.10	0.15	0.70	3og	11
	DE1-030BB10-01A0	1	12.30	0.30	Conical/ 1.10	0.20	Conical/ 1.10	0.20	1.25	20g	50
	DE1-030BB50-01A0	1	6.7	0.30	Conical/ 1.20	0.18	Conical/ 0.50	0.15	0.65	13g	50
	PE3-030DF17-03A0	3	3.25	0.30	Crown/ 0.95	0.18	Round/ 0.50	0.16	0.35	27g	12
	PE3-030DF18-01A0	3	2.90	0.30	Crown/ o.6o	0.20	Round/ 0.50	0.15	0.40	359	12
0.4	DE3-030BF21-03F0	3	3.30	0.30	Crown/ o.6o	0.22	Conical/ o.6o	0.15	0.40	3og	13
	PE3-030EL25-01A0	3	3.89	0.30	Blade/ o.68	0.20	Conical/ 0.65	0.15	0.45	25g	40
	DE1-030DF40-05A0	3	5.70	0.30	Crown/ 1.10	0.15	Round/ o.6o	0.15	0.50	25g	48
	PE3-030EF53-01A0	3	7.00	0.30	Crown/ o.70	0.20	Conical/ 0.90	0.15	0.55	25g	29
	PE3-031DF17-03F0	3	2.85	0.31	Crown/ o.55	0.20	Round/ 0.50	0.16	0.35	359	13
	PE3-031DF21-03F0	3	3.30	0.31	Crown/ o.50	0.20	Round/ o.6o	0.16	0.40	359	14
	WE1-031BB23-01A0	1	3.30	0.31	Conical/ 0.50	0.16	Conical/ 0.50	0.16	0.50	25g	45
	WE1-031BF23-01A0	1	3.30	0.31	Crown/ o.50	0.16	Conical/ 0.50	0.16	0.50	3og	46
	PE1-031EF23-02F0	1	3.30	0.31	Crown/ o.6o	0.16	Conical/ 0.40	0.16	0.40	3og	14
	PE1-031EF30-02F0	1	4.00	0.31	Crown/ o.6o	0.16	Conical/ 0.40	0.16	0.60	3 <b>1</b> g	15
	PE1-031DF30-01F0	1	4.00	0.31	Crown/ o.6o	0.16	Round/ o.40	0.16	0.60	31g	15
	DE1-031BF32-02A0	1	4.75	0.31	Conical/ 1.10	0.16	Crown/ o.45	0.16	0.60	259	16
	PE3-031EL38-01A0	3	5.44	0.31	Blade/ o.77	0.30	Conical/ o.87	0.15	0.60	359	40
	DE1-031DD40-01W1	3	5.70	0.31	Round/ 1.10	0.15	Round/ o.6o	0.15	0.80	25g	48
	DE3-031DD50-01A0	3	9.08	0.31	Round/ 2.00	0.23	Round/ 2.00	0.18	1.00	20g	51
	PE4-032DF24-03F0	4	3.30	0.39	Crown/ o.30	0.31	Round/ o.6o	0.15	0.40	3og	16

Except the specifications in the table, we provide customization according to your specifications.





Pitch   Pitc												
PE4-035DE09-01H0   4   1.23   0.43     -   Roundl 0.26   0.17   0.18   159   36	Pitch	P/N	Type	Length	/Ring	Plunger A Type/ Length	Plunger A OD	Plunger C Type/ Length	_	_	±20%	Spec
DE1-035BE12-01A0	, recir	1713	1,750			(L1)	(фА)	(L3)	(фС)			(10090)
DE <sub>4</sub> -035DH2 <sub>4</sub> -01A0		PE4-035DE09-01H0	4	1.23	0.43	-	-	Round/ 0.26	0.17	0.18	159	36
PE4-035DF24-01F0		DE1-035BE12-01A0	1	2.00	0.35	Conical/ 0.50	0.20	Conical/ 0.30	0.20	0.30	18g	17
PE1-036EF25-01F0		DE4-035DH24-01A0	4	3.35	0.42	Serrated/ 0.25	0.33	Round/ 0.70	0.18	0.50	279	43
PE3-038DF17-03F0   3   3.15   0.38   Crown/0.75   0.23   Round/0.55   0.20   0.38   38g   18		PE4-035DF24-01F0	4	3.35	0.40	Crown/ 0.25	0.34	Round/ 0.70	0.20	0.45	32g	17
PE3-038EF17-04AO   3   2.85   0.38   Crown/ 0.50   0.22   Conical/ 0.50   0.22   0.35   309   19     PE1-038DF32-02F0   1   4.80   0.38   Crown/ 1.10   0.21   Round/ 0.55   0.20   0.65   379   19     PE1-038EP40-01AO   1   5.70   0.38   Crown/ 1.10   0.22   Conical/ 0.60   0.22   0.65   4.09   20     PE3-040BF34-01AO   3   5.70   0.40   Crown/ 1.13   0.32   Conical/ 0.60   0.22   0.70   309   20     DE1-040BF39-030   1   5.20   0.40   Crown/ 0.65   0.23   Conical/ 0.65   0.20   0.65   2.59   21     DE3-040DD50-01AO   3   9.20   0.40   Round/ 2.00   0.30   Round/ 2.20   0.20   0.65   2.59   21     DE3-040DD85-01AO   3   15.55   0.40   Round/ 3.50   0.30   Round/ 3.50   0.20   2.50   2.29   52     DE4-048EF17-01F0   4   2.65   0.55   Crown/ 0.20   0.47   Conical/ 0.55   0.28   0.40   309   37     DE2-050EF25-12O   2   3.40   0.65   Crown/ 0.50   0.30   Conical/ 0.35   0.30   0.40   359   42     PE4-045EF09-01F0   4   2.57   0.62   Crown/ 0.30   0.30   Conical/ 0.30   0.30   0.40   359   42     PE4-052DF17-01F0   4   2.57   0.62   Crown/ 0.30   0.51   Round/ 1.00   0.25   0.60   409   23     DE4-052EF23-02F0   4   3.35   0.61   Crown/ 0.30   0.51   Round/ 1.00   0.25   0.60   409   23     DE4-056EF09-03F0   4   1.50   0.65   -		PE1-035EF25-01F0	1	3.50	0.35	Crown/ o.6o	0.20	Conical/ 0.40	0.20	0.60	32g	18
PE1-038DF32-02F0		PE3-038DF17-03F0	3	3.15	0.38	Crown/ 0.75	0.23	Round/ 0.55	0.20	0.38	38g	18
PE1-038EP40-01A0	0.5	PE3-038EF17-04A0	3	2.85	0.38	Crown/ o.50	0.22	Conical/ 0.50	0.22	0.35	3og	19
PE3-040BF34-01A0		PE1-038DF32-02F0	1	4.80	0.38	Crown/ 1.10	0.21	Round/ 0.55	0.20	0.65	379	19
DE1-040BF39-030		PE1-038EP40-01A0	1	5.70	0.38	Crown/ 1.10	0.22	Conical/ o.6o	0.22	0.65	40g	20
DE3-040DD50-01A0   3   9.20   0.40   Round/ 2.00   0.30   Round/ 2.20   0.20   1.00   20g   51     DE3-040DD85-01A0   3   15.55   0.40   Round/ 3.50   0.30   Round/ 3.50   0.20   2.50   22g   52     PE4-045EF09-01A0   4   1.50   0.54   -		PE3-040BF34-01A0	3	5.70	0.40	Crown/ 1.13	0.32	Conical/ 1.07	0.22	0.70	3og	20
DE3-040DD85-01A0   3   15.55   0.40   Round/3.50   0.30   Round/3.50   0.20   2.50   22g   52		DE1-040BF39-030	1	5.20	0.40	Crown/ o.65	0.23	Conical/ o.65	0.20	0.65	259	21
PE4-045EF09-01A0		DE3-040DD50-01A0	3	9.20	0.40	Round/ 2.00	0.30	Round/ 2.20	0.20	1.00	20g	51
DE4-048EF17-01F0		DE3-040DD85-01A0	3	15.55	0.40	Round/ 3.50	0.30	Round/ 3.50	0.20	2.50	22g	52
DE2-050EF25-120 2 3.40 0.65 Crown/ 0.50 0.30 Conical/ 0.35 0.30 0.40 359 42  PE2-050EF25-01F0 2 3.35 0.66 Crown/ 0.50 0.30 Conical/ 0.30 0.30 0.45 359 22  PE4-052DF17-01F0 4 2.57 0.62 Crown/ 0.40 0.51 Round/ 0.57 0.25 0.40 309 22  PE4-052DF28-01F0 4 4.20 0.60 Crown/ 0.40 0.51 Round/ 0.57 0.25 0.60 409 23  DE4-052EF23-02F0 4 3.35 0.61 Crown/ 0.30 0.50 Conical/ 0.75 0.30 0.45 359 24  DE4-056EF09-03F0 4 1.50 0.65 Conical/ 0.55 0.38 0.40 319 42  PE4-056EF09-01H0 4 1.50 0.65 Conical/ 0.55 0.38 0.40 319 37  PE4-056DF20-02F0 4 3.05 0.65 Crown/ 0.30 0.54 Round/ 0.70 0.30 0.50 359 24  DE3-056BE34-01A0 3 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 31  WE3-056BE34-02A0 4 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 46  PE1-058EE40-01A0 1 5.75 0.58 Conical/ 0.94 0.40 Conical/ 0.05 0.30 0.80 28g 43  PE4-065EW15-01A0 4 2.5 0.65 Serrated/ 0.60 0.53 Conical/ 0.70 0.42 0.50 329 24  0.8 PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 409 25  DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 209 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 0.40 0.90 Conical/ 0.65 0.50 0.70 309 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 309 26		PE4-045EF09-01A0	4	1.50	0.54	-	-	Conical/ 0.55	0.28	0.40	3og	37
0.6 PE2-050EF25-01F0 2 3.35 0.66 Crown/ 0.50 0.30 Conical/ 0.30 0.30 0.45 359 22 PE4-052DF17-01F0 4 2.57 0.62 Crown/ 0.30 0.51 Round/ 0.57 0.25 0.40 309 22 PE4-052DF28-01F0 4 4.20 0.60 Crown/ 0.40 0.51 Round/ 1.00 0.25 0.60 409 23 DE4-052EF23-02F0 4 3.35 0.61 Crown/ 0.30 0.50 Conical/ 0.75 0.30 0.45 359 24 PE4-056EF09-03F0 4 1.50 0.65 - Conical/ 0.55 0.38 0.40 319 37 PE4-056EF09-01H0 4 1.50 0.65 - Conical/ 0.55 0.38 0.40 319 37 PE4-056DF20-02F0 4 3.05 0.65 Crown/ 0.30 0.54 Round/ 0.70 0.30 0.50 359 24 DE3-056BE34-01A0 3 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 31 WE3-056BE34-02A0 4 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 46 PE1-058EE40-01A0 1 5.75 0.58 Conical/ 0.94 0.40 Conical/ 0.05 0.30 0.80 289 43 PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 409 25 DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.50 0.70 309 26 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.50 0.50 0.70 309 26 DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 309 26		DE4-048EF17-01F0	4	2.65	0.55	Crown/ 0.20	0.47	Conical/ 0.75	0.25	0.50	27.5g	21
PE4-052DF17-01F0		DE2-050EF25-120	2	3.40	0.65	Crown/ o.50	0.30	Conical/ 0.35	0.30	0.40	359	42
PE4-052DF28-01F0	0.6	PE2-050EF25-01F0	2	3.35	o.66	Crown/ o.50	0.30	Conical/ 0.30	0.30	0.45	359	22
DE4-o52EF23-o2F0		PE4-052DF17-01F0	4	2.57	0.62	Crown/ o.3o	0.51	Round/ 0.57	0.25	0.40	30g	22
DE4-o56EFo9-o3Fo		PE4-052DF28-01F0	4	4.20	0.60	Crown/ o.40	0.51	Round/ 1.00	0.25	0.60	40g	23
PE4-o56EFo9-o1Ho		DE4-052EF23-02F0	4	3.35	0.61	Crown/ o.30	0.50	Conical/ 0.75	0.30	0.45	359	24
PE4-056DF20-02F0		DE4-056EF09-03F0	4	1.50	0.65	-	-	Conical/ 0.55	0.38	0.40	319	42
0.7 DE3-056BE34-01A0 3 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 31 WE3-056BE34-02A0 4 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 46 PE1-058EE40-01A0 1 5.75 0.58 Conical/ 1.10 0.30 Conical/ 0.65 0.30 0.80 289 43  PE4-065EW15-01A0 4 2.5 0.65 Serrated/ 0.60 0.53 Conical/ 0.70 0.42 0.50 329 24  PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 409 25 DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 209 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 309 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 309 26		PE4-056EF09-01H0	4	1.50	0.65	-	-	Conical/ 0.55	0.38	0.40	319	37
DE3-056BE34-01A0 3 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 31  WE3-056BE34-02A0 4 5.39 0.56 Conical/ 0.94 0.40 Conical/ 1.00 0.30 0.67 359 46  PE1-058EE40-01A0 1 5.75 0.58 Conical/ 1.10 0.30 Conical/ 0.65 0.30 0.80 289 43  PE4-065EW15-01A0 4 2.5 0.65 Serrated/ 0.60 0.53 Conical/ 0.70 0.42 0.50 329 24  PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 409 25  DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 209 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 309 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 309 26		PE4-056DF20-02F0	4	3.05	0.65	Crown/ o.3o	0.54	Round/ 0.70	0.30	0.50	359	24
PE1-058EE40-01A0 1 5.75 0.58 Conical/ 1.10 0.30 Conical/ 0.65 0.30 0.80 28g 43  PE4-065EW15-01A0 4 2.5 0.65 Serrated/ 0.60 0.53 Conical/ 0.70 0.42 0.50 32g 24  PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 40g 25  DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 20g 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 30g 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 30g 26	0.7	DE3-056BE34-01A0	3	5.39	0.56	Conical/ 0.94	0.40	Conical/ 1.00	0.30	0.67	359	31
0.8 PE4-065EW15-01A0 4 2.5 0.65 Serrated/ 0.60 0.53 Conical/ 0.70 0.42 0.50 32g 24  PE4-068EP35-01F0 4 4.45 0.80 Crown/ 0.40 0.67 Conical/ 0.90 0.35 0.65 40g 25  DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 20g 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 30g 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 30g 26		WE3-056BE34-02A0	4	5.39	0.56	Conical/ 0.94	0.40	Conical/ 1.00	0.30	0.67	359	46
0.8 PE4-068EP35-01F0		PE1-058EE40-01A0	1	5.75	0.58	Conical/ 1.10	0.30	Conical/ o.65	0.30	0.80	28g	43
DE1-072EE50-01A0 1 7.20 0.72 Conical/ 1.70 0.40 Conical/ 0.50 0.40 1.20 20g 25  0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 30g 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 30g 26		PE4-065EW15-01A0	4	2.5	0.65	Serrated/ o.6o	0.53	Conical/ 0.70	0.42	0.50	32g	24
0.9 DE1-080BF40-010 1 5.80 0.80 Crown/ 1.15 0.50 Conical/ 0.65 0.50 0.70 30g 26  DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 30g 26	0.8	PE4-068EP35-01F0	4	4.45	0.80	Crown/ o.4o	0.67	Conical/ 0.90	0.35	0.65	40g	25
DE4-090EF25-02F0 4 3.20 1.00 Crown/ 0.40 0.90 Conical/ 0.70 0.63 0.50 30g 26		DE1-072EE50-01A0	1	7.20	0.72	Conical/ 1.70	0.40	Conical/ 0.50	0.40	1.20	20g	25
1.0	0.9	DE1-080BF40-010	1	5.80	0.80	Crown/ 1.15	0.50	Conical/ 0.65	0.50	0.70	3og	26
		DE4-090EF25-02F0	4	3.20	1.00	Crown/ o.4o	0.90	Conical/ 0.70	0.63	0.50	3og	26
	1.0	DE1-091DD10-01A0	1	13.70	0.91	Round/ 1.80	0.50	Round/ 1.80	0.50	2.00	50g	52











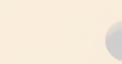


















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